

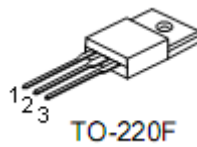
1. Applications

- n Adaptor
- n Charger
- n SMPS Standby Power

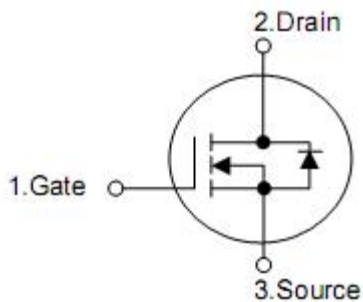
2. Features

- n RoHS Compliant
- n $R_{DS(on)} = 0.7\Omega$ (typ.) @ $V_{GS} = 10\text{ V}$
- n Low gate charge minimize switching loss
- n Fast recovery body diode

3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source



4. Ordering Information

Part Number	Package	Brand
KNF4850A	TO-220F	KIA

5. Absolute maximum ratings

(T_C=25 °C , unless otherwise specified)

Parameter	Symbol	Ratings	Units
Drain-source voltage	V _{DSS}	500	V
Gate-source voltage	V _{GSS}	±30	V
Continuous drain current	I _D	9.0*	A
Pulsed drain current at V _{GS} =10V	I _{DM}	32*	A
Single pulse Avalanche energy	E _{AS}	400	mJ
Peak diode recovery dv/dt	dv/dt	5.5	V/ns
Power dissipation	P _D	36	W
		Derating factor above 25°C	0.96
Soldering temperature distance of 1.6mm from case for 10seconds	T _L	300	°C
Operating and Storage temperature range	T _J & T _{STG}	-55~+150	°C

*Drain current limited by maximum junction temperature

Caution: Stresses greater than those listed in the “ Absolute maximum ratings” may cause permanent damage to the device.

5. Thermal characteristics

Parameter	Symbol	Rating	Unit
Thermal resistance,Junction-to-case	θ _{JC}	3.52	°C/W
Thermal resistance,Junction-to-ambient	θ _{JA}	62.5	°C/W

6. Electrical characteristics

($T_J=25^\circ\text{C}$, unless otherwise notes)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	500	-	-	V
Gate source breakdown voltage	V_{GSO}	$I_{GS}=\pm 1mA$ (Open drain)	± 30	-	-	V
Drain-to-source leakage current	I_{DSS}	$V_{DS}=500V, V_{GS}=0V$	-	-	1	μA
		$V_{DS}=400V, V_{GS}=0V, T_J=125^\circ C$	-	-	100	μA
Gate-to-source leakage current	I_{GSS}	$V_{GS}=20V, V_{DS}=0V$	-	-	10	μA
		$V_{GS}=-20V, V_{DS}=0V$	-	-	-10	μA
On characteristics						
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	-	4.0	V
Static drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=4A$	-	0.7	0.9	Ω
Forward transconductance	g_{fs}	$V_{DS}=15V, I_D=3A$	-	8.5	-	S
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{DS}=25V, V_{GS}=0V, f=1.0MHz$	-	960	-	pF
Output capacitance	C_{oss}		-	110	-	pF
Reverse transfer capacitance	C_{rss}		-	10	-	pF
Gate resistance	R_g	$V_{DS}=0V, F=1MHz$	-	1.3	-	Ω
Total gate charge	Q_g	$V_{DD}=30V, V_{GS}=0V-10V, I_D=8A(TO-252) I_D=9A(TO-220)$	-	24	-	nC
Gate-source charge	Q_{gs}		-	4.0	-	nC
Gate-drain (Miller) charge	Q_{gd}		-	10	-	nC
Resistive switching characteristics						
Turn-on delay time	$t_{d(ON)}$	$V_{DD}=250V, V_{GS}=10V, R_g=12\Omega, I_D=8A(TO-252) I_D=9A(TO-220)$	-	11	-	nS
Rise time	t_{rise}		-	17	-	
Turn-off delay time	$t_{d(OFF)}$		-	46	-	
Fall time	t_{fall}		-	22	-	
Source-drain body diode characteristics $T_J=25^\circ\text{C}$, unless otherwise notes						
Diode forward voltage	V_{SD}	$V_{GS}=0V, I_S=8A(TO-252) I_S=9A(TO-220)$	-	-	1.5	V
Continuous source current(TO-252) ²	I_{SD}	Intergra PN-diode in MOSFET	-	-	8	A
Continuous source current(TO-220) ²	I_{SD}		-	-	9	A
Pulsed source current ²	I_{SM}		-	-	32	A
Reverse recovery time	t_{rr}	$di_F/dt=100A/\mu s, V_{GS}=0V$	-	175	-	ns
Reverse recovery charge	Q_{rr}	$I_F=8A(TO-252) I_F=9A(TO-220)$	-	750	-	nC

Note: 1. $T_J=25^\circ\text{C}$ to 150°C

2. Pulse width $\leq 380\mu s$; duty cycle $\leq 2\%$.

3. KIA finished product specifications please customer before placing order, should obtain the latest version of the finished product specifications.

7. Typical operating characteristics

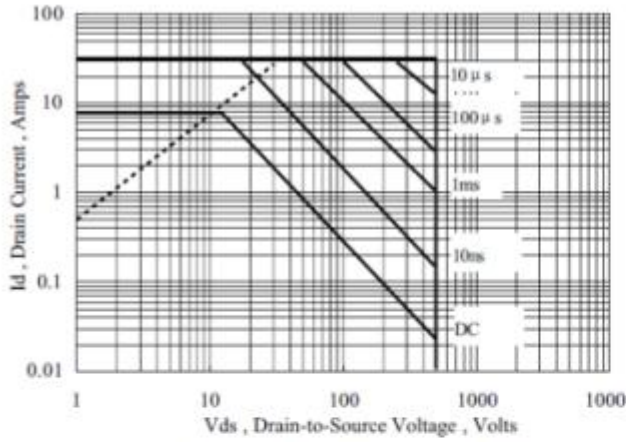


Figure 1 Maximum Forward Bias Safe Operating Area

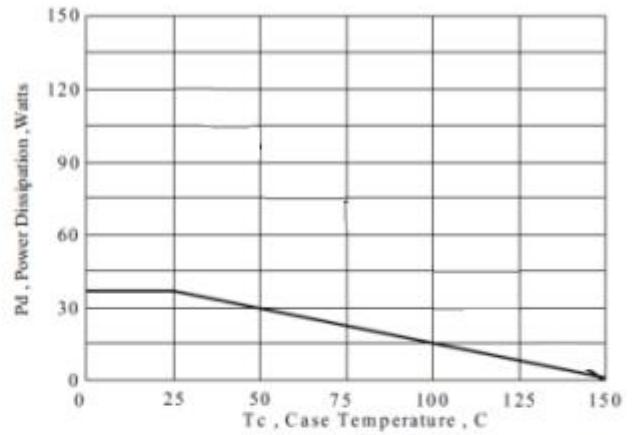


Figure 2 Maximum Power Dissipation vs Case Temperature

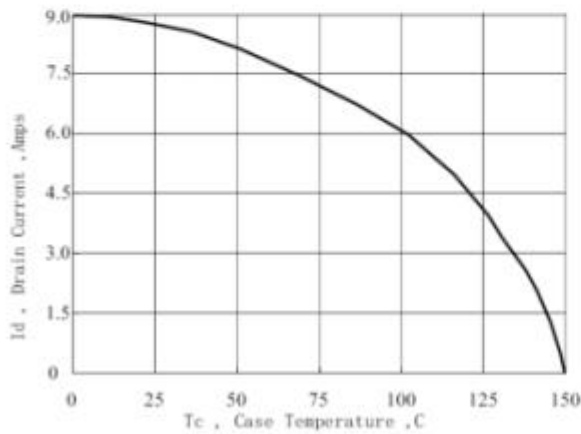


Figure 3 Maximum Continuous Drain Current vs Case Temperature

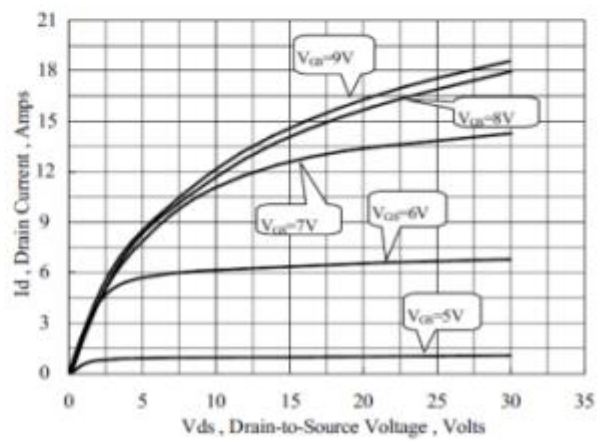


Figure 4 Typical Output Characteristics

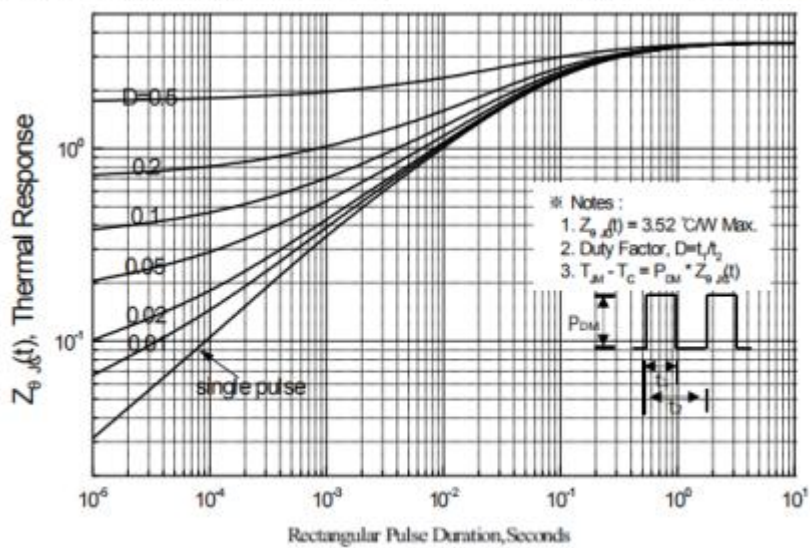


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

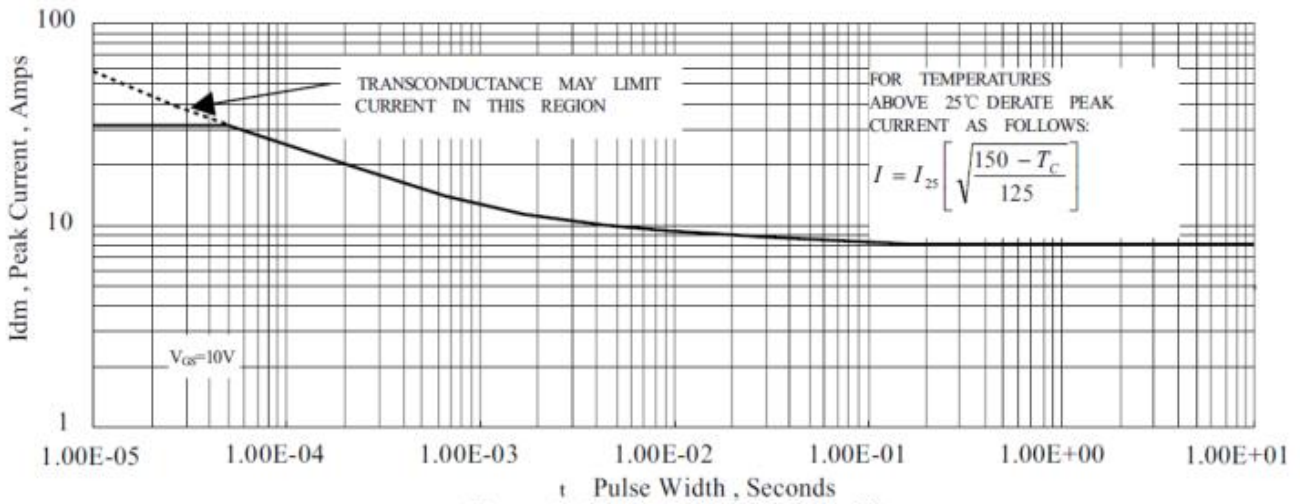


Figure 6 Maximum Peak Current Capability

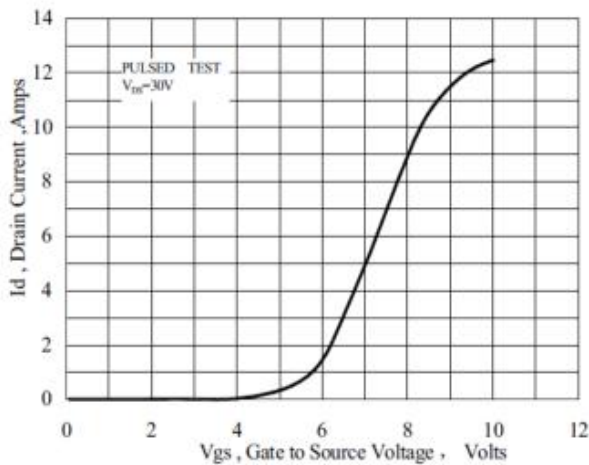


Figure 7 Typical Transfer Characteristics

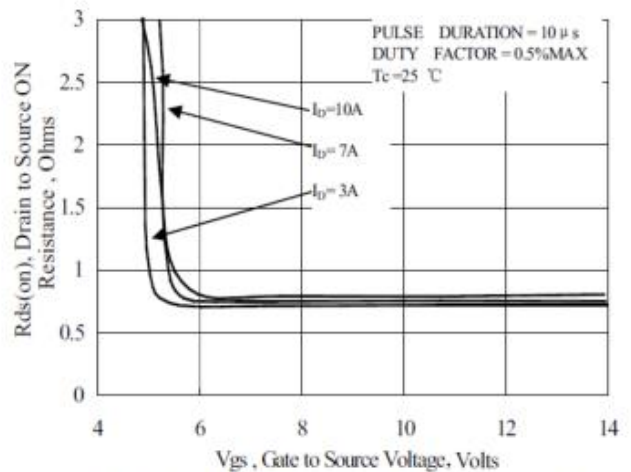


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage

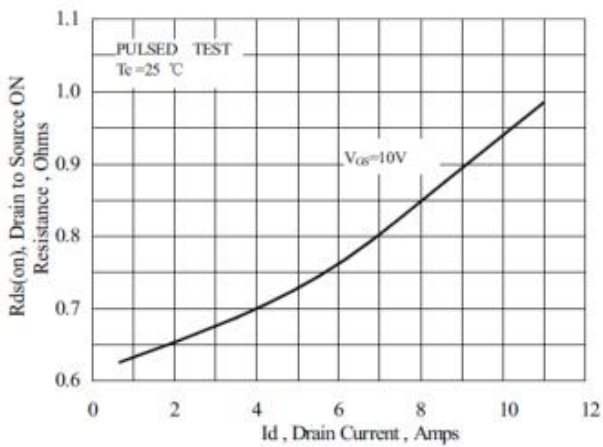


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

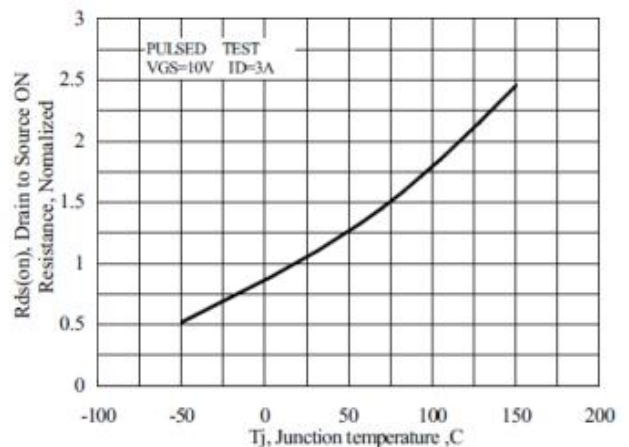


Figure 10 Typical Drain to Source ON Resistance vs Junction Temperature

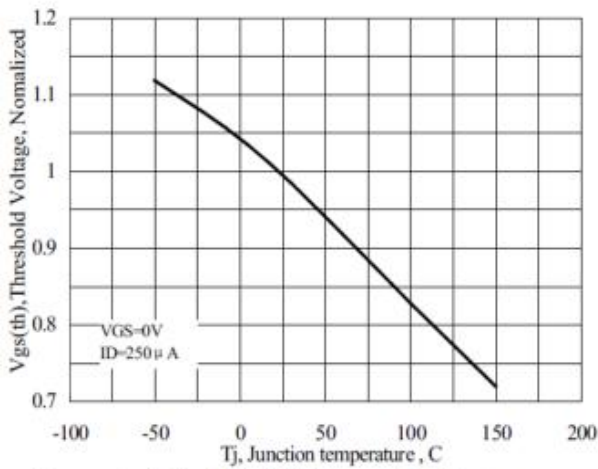


Figure 11 Typical Theshold Voltage vs Junction Temperature

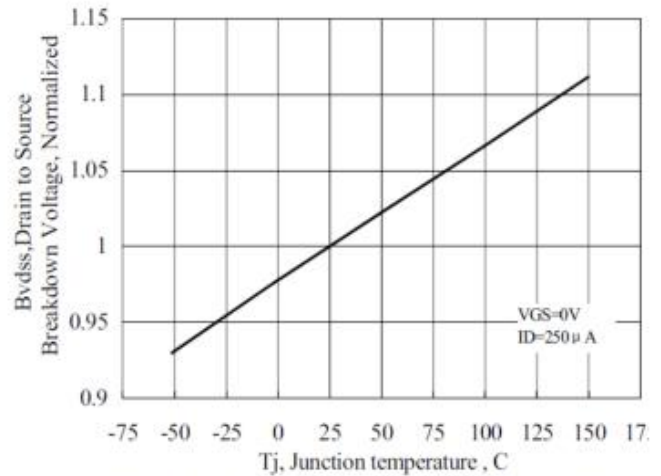


Figure 12 Typical Breakdown Voltage vs Junction Temperature

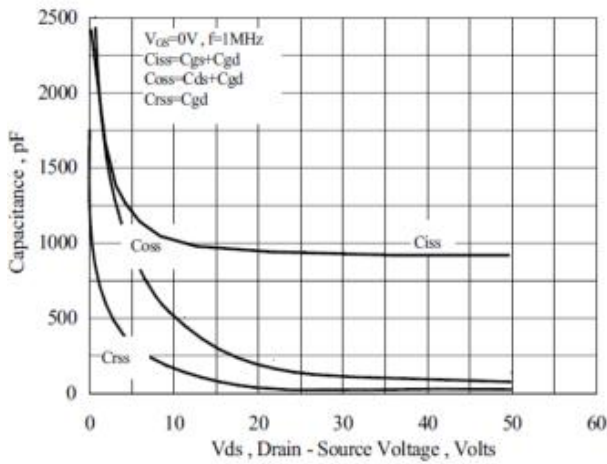


Figure 13 Typical Capacitance vs Drain to Source Voltage

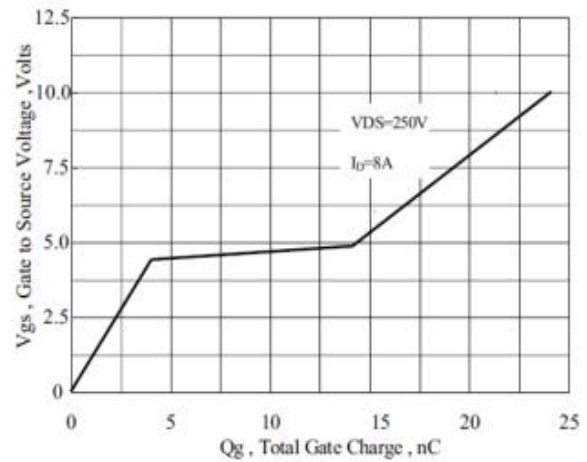


Figure 14 Typical Gate Charge vs Gate to Source Voltage

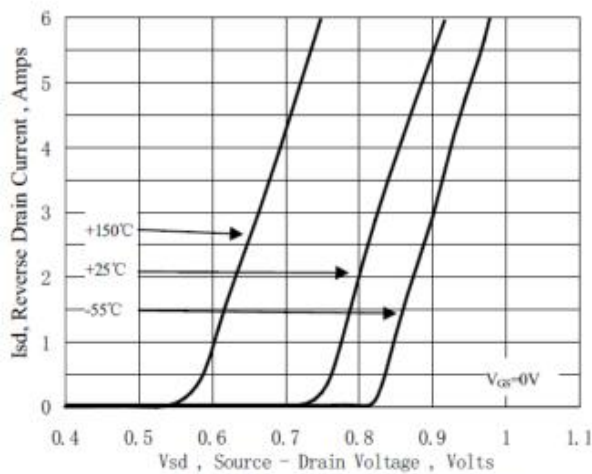


Figure 15 Typical Body Diode Transfer Characteristics

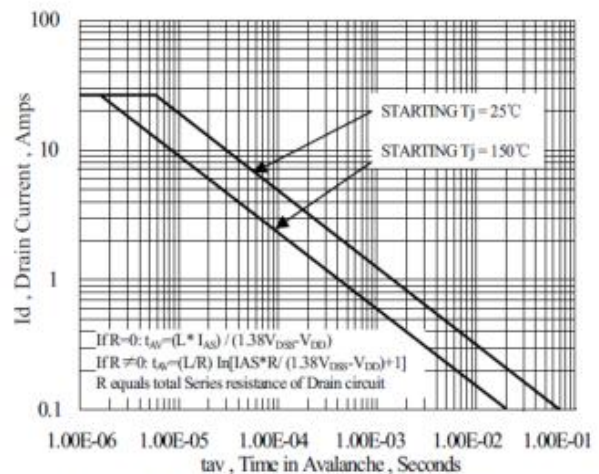


Figure 16 Unclamped Inductive Switching Capability